



Design Objectives

- Treatment Comparison
- Screening
- Model Building
- Parameter Estimation
- Optimization
- Prediction
- Confirmation
- Discovery (Random Shot)

♦ etc.

Design Methodology

- Treatment Comparison
- Fractional & Full Factorial Design
- Orthogonal Arrays
- Combinatorics Design
- Coding Theory
- Response Surface Methodology
- ANOVA type Design
- Optimal Design
- Bayesian (Optimal) Design

Design Methodology (Continued)

- Saturated (Minimal Point) Design
- Taguchi Product (Robust) Design
- Mixture Experiment
- Computer Experiment
- Supersaturated Design
- Uniform Design
- MicroArray Design

Design of Experiment (Lin)

- Multiple Response Problems
 Optimization: Kim and Lin (*JRSS-C*, 2000)
 Design: Chang, Lo, Lin & Young (*JSPI*, 2001)
- Computer Experiment
 Reattie and Lin (1999, 2005)
- Dispersion Effect

 McGrath and Lin (*Technometrics*, 2002)

 Foldover Plan
- Supersaturated Designs

 ALin (*Technometrics*, 1993, 1995, 2001) and others
- Uniform Designs
 Rang, Lin, Winker & Yang (*Technometrics*, 1999)



Injection Molding Process

Y = % shrinkage

 X_1 (A) = mold temperature X_2 (B) = screw speed X_3 (C) = holding time X_4 (D) = gate size







Traditional Method of Identifying Dispersion Effects in Unreplicated Fractional Factorials

Box and Meyer (1986b) and Montgomery (1990)

- 1. Identify location effects
- 2. Fit reduced model and calculate residuals
- 3. For column d, calculate $F_d^* = ln \frac{s_{d+}^2}{s_{d-}^2}$ (natural log of ratio of sample variance of residuals at $d = \pm 1$.)
- 4. Box and Meyer point out this statistic is *approximately* normally distributed with mean 0.
- 5. Montgomery (1990) use a normal probability plot of the F_d^* to identify dispersion effects.

		Two	Feas	ible I	Mod	els		
Model I: $\hat{y} = \hat{\beta}_0$	$+ \hat{\beta}_1 x_1 +$	$\hat{\beta}_{2}x_{2} +$	$\hat{\beta}_5 x_5$					
Model II: $\hat{y} = \hat{\beta}$	$_{0} + \hat{\beta}_{1}x_{1} +$	$\hat{\beta}_2 x_2 +$	$\hat{\beta}_{5}x_{5} +$	$\hat{\beta}_{7}x_{7} +$	$\hat{\beta}_{13}x_{13}$	3		
			Model I		Ν	Model	П	
	Column	s_{j+}^{2}	s_{j-}^{2}	F_j^*	s_{j+}^{2}	s_{j-}^{2}	F_j^*	
	1	14.43	21.11	-0.38	3.26	2.19	0.40	
	2	16.11	19.43	-0.19	3.19	2.26	0.34	
	3	32.44	2.66	2.50	2.42	2.58	-0.06	
	4	21.55	12.91	0.51	1.98	2.39	-0.19	
	5	18.71	16.82	0.11	4.33	1.12	1.36	
	6	13.55	20.48	-0.41	1.95	1.99	-0.02	
	7	11.48	7.55	0.42	2.25	3.20	-0.35	
	8	14.80	18.73	-0.24	2.02	1.42	0.36	
	9	16.08	19.44	-0.19	2.08	3.35	-0.48	
	10	22.23	13.30	0.51	2.19	3.25	-0.39	
	11	17.41	18.05	-0.04	3.17	2.20	0.36	
	12	22.30	13.23	0.52	2.03	3.41	-0.52	
	13	12.23	9.73	0.23	1.29	4.16	-1.17	
	14	15.05	20.41	-0.30	1.16	4.21	-1.29	
	15	92.76	1155	0.79	2.06	9.96	0.97	



F^{ML}, Testing in Presence of Multiple Dispersion Effects

1. Identify location effects.

5.

2. Adapt the location effect model to include exactly the following *a* terms:

- The overall mean (β_0) ,
- All active location effects and their interactions,
- The location effects of the columns to be tested for dispersion and their interactions, and
- The interactions of all of the above.
- 3. Identify the C_q s, $q = 1, \dots, m$, the *m* sets of residuals from rows that are identical for the above columns.
- 4. Calculate s_q^2 as $\sum_{e_i \in C_q} e_i^2/(n/m-1)$, i.e. the sample variance of the residuals for each C_q . Each of these sample variance has d = (n-a)/mdegrees of freedom. $F_j^{ML} = \left(\prod_{q:C_q \subset P_j} s_q^2 \prod_{q:C_q \subset M_j} s_q^{-2}
 ight)^{
 m :}$

$$\begin{aligned} & \textbf{Multiple Dispersion Effects (McGrath and Lin, 2001)} \\ & \text{Instead of} \\ & D_E^{BH} = \frac{\sum_{q:C_q \subset P_E} s_q^2}{\sum_{q:C_q \subset M_E} s_q^2} = \frac{s_1^2 + s_2^2}{s_3^2 + s_4^2} \\ & \text{use} \\ & F_E^{ML} = \frac{(\Pi_{q:C_q \subset P_E} s_q^2)^{1/2}}{(\Pi_{q:C_q \subset M_E} s_q^2)^{1/2}} = \frac{(s_1^2 \times s_2^2)^{1/2}}{(s_3^2 \times s_4^2)^{1/2}} \\ & \text{Then,} \\ & R_E^{ML} = \frac{(\Delta_E / \Delta_D \Delta_{DE})^{1/2} \times (\Delta_D \Delta_E \Delta_{DE})^{1/2}}{(\Delta_{DE} / \Delta_D \Delta_E)^{1/2} \times (\Delta_D / \Delta_E \Delta_{DE})^{1/2}} = \Delta_E \end{aligned}$$



Uniform Design

A uniform design provides uniformly scatter design points in the experimental domain.

http://www.math.hkbu.edu.hk/UniformDesign

Uniform Design

 $\hat{F}_{n}(x) = \text{Empirical Cumulative Distribution Function}$ F(x) = Uniform Cumulative Distribution FunctionFind $x = (x_{1}, x_{2}, ..., x_{n})$ such that $\hat{F}_{n}(x)$ is closest to F(x).
Discrepancy $D = \left[\int_{\Omega} \left\| \hat{F}_{n}(x) - F(x) \right\|^{p} dx \right]^{\frac{1}{p}}$ • Wang & Fang (1980)

The centered L_p -discrepancy is invariant under exchanging coordinates from x to 1-x. Especially, the centered L_2 -discrepancy, denoted by CL_2 , has the following computation formula:

 $(CL_2(\mathbf{P}))^2$

 $= \left(\frac{13}{12}\right)^{s} - \frac{2}{n} \sum_{k=1}^{n} \prod_{i=1}^{s} \left(1 + \frac{1}{2} |x_{ki} - \frac{1}{2}| - \frac{1}{2} |x_{ki} - \frac{1}{2}|^{2}\right)$ $+\frac{1}{n^2}\sum_{k=1}^n\sum_{j=1}^n\prod_{i=1}^s\left[1+\frac{1}{2}\mid x_{ki}-\frac{1}{2}\mid+\frac{1}{2}\mid x_{ji}-\frac{1}{2}\mid-\frac{1}{2}\mid x_{ki}-x_{ji}\mid\right].$

nifo	rm D	esig	n Ex	amp	le				
					1				
No.	1	2	3	4	x_1	x_2	x_3	<i>x</i> ₄	у
1	11	8	2	10	5.0	40	1.5	60	0.1836
2	9	7	12	8	4.2	35	6.5	50	0.1739
3	8	2	3	2	3.8	10	2.0	20	0.0900
4	10	12	6	4	4.6	60	3.5	30	0.1176
5	1	10	4	7	1.0	50	2.5	45	0.0795
6	2	5	11	3	1.4	25	6.0	25	0.0118
7	4	6	1	5	2.2	30	1.0	35	0.0991
8	7	4	3	12	3.4	20	3.0	70	0.1319
9	6	9	8	1	3.0	45	4.5	15	0.0717
10	3	1	7	9	1.8	5	4.0	55	0.0109
11	5	11	10	11	2.6	55	5.5	65	0.1266
12	12	3	9	6	5.4	15	5.0	40	0.1424











Uniform Design: Summary

- Uniformity
- Model Robustness
- Flexibility in experimental runs
- Flexibility in the number of levels

References

- Fang and Lin (2003)
 - Handbook of Statistics, Statistics in Industry (Vol.22).
- Fang, Lin, Winker and Zhang (Technometrics, 2000)
- Website www.math.hkbu.edu.hk/UniformDesign





A crimp example

- Goal: determine the effect of post crimp stresses on the crimp resistance
- Design: 5=1234, 6=124

1:crimp height, 2: pro-conditioning thermal shock, 3: dry heat soak, 4: fixture material, 5: thermal shock life test, 6: discoloration

- Original design: 16-run design
- How do we conduct the next 16-run design?

Notations

- Factors: 1, 2, 3, 4
- Generators: 5=12, 6=134
- Defining relation: I=125=1346=23456
- Word length pattern: W=(0,0,1,1,1)
- Resolution: III
- Foldover plan: γ^{f} =123456
- WLP of the combined design: W=(0,0,0,1,0)

Resolution, Aberration and WLP

- Higher resolution implies less confounding
 - Resolution III designs confound main effects and two-factor interactions
 - Resolution IV designs confound two-factor interactions with some two-factor interactions
- WLP (Word Length Pattern) is used to further distinguish designs with same resolution--aberration criterion.

Properties of foldover designs

Pros

Reasy to construct Can "separate" effects

- Combined design still orthogonal
- Cons

 Alarge run size

• Our objective:

Not to compare foldover with other follow-up strategies, but to give the "optimal" foldover among all possible foldover plans

- <u>Question</u>: In the previous example, in which 5=12, 6=134, is there a "better" foldover plan in terms of WLP of combined design?
- <u>Answer</u>: γ*=56 (why???) (Trust Dennis!)
- <u>Objective</u>: Given a fractional factorial design with economic run size (16 & 32), find its "optimal" foldover plan in terms of the aberration of the combined design.

Core Plan

For any 2^{k-p} design with p generators (G_1, \dots, G_p) , any foldover plan is equivalent to a core foldover plan.

Moreover, for every core foldover plan, there are 2^{k-p} foldover plans that are equivalent to it.

Equivalence of foldover designs





Foldover of resolution III designs

Design	Initial W(d)	$W(D(\gamma^{-1}))$	$W(D(\gamma))$	Optimal foldove
k-p		of full-foldover	of optimal foldover	plan (γ*)
6-2.2	(1 1 1 0)	(0 1 0 0 0)	(0 0 1 0 0)	56
7-3.2	(2 3 2 0 0)	(0 3 0 0 0)	(0 1 2 0 0)	567
8-4.2	(37401)	(07000)	(0 3 4 0 0)	5678
8-4.4	(4 6 4 0 0)	(0 6 0 0 0)	(0 3 4 0 0)	567
9-5.1	(4 14 8 0 4)	(0 14 0 0 0)	(06800)	5678
7-2.5	(1 1 0 0 1)	(0 1 0 0 0)	(0 0 0 0 1)	67
8-3.5	(1 2 3 1 0)	(0 2 0 1 0)	(0 0 2 1 0)	678
9-4.6	(15621)	(0 5 0 2 0)	(0 1 4 2 0)	6789
9-4.7	(17403)	(07000)	(0 3 2 0 2)	67,,69
9-4.8	(23640)	(0 3 0 4 0)	(0 1 4 2 0)	6,786,789,679
10-5.5	(1 14 7 0 7)	(0 14 0 0 0)	(0 6 4 0 4)	678,, 6910
11-6.6	(3 13 19 11 9)	(0 13 0 11 0)	(0 5 12 7 4)	678

A Typical Example

- Factors: 1, 2, 3, 4
- Generators: 5=12, 6=134
- Defining relation: I=125=1346=23456
- Word length pattern: *W*=(0,0,1,1,1,0)_{III}
- Full Foldover plan: γ =123456 [γ =5]
- WLP of the combined design: W=(0,0,0,1,0,0)_{IV}
- Optimal Foldover plan: γ*=56
- WLP of the combined design: W=(0,0,0,0,1,0)v

Foldover of resolution IV designs

Li & Lin (2003)

Design	Initial W(d)	$W(\boldsymbol{D}(\gamma^{f}))$	$W(\boldsymbol{D}(\gamma^{-1}))$	Optimal foldover
k-p		of full-foldover	of optimal foldover	plan (γ*)
5-1.2	(0 1 0)	(0 1 0 0 0)	full factorial	5
6-2.1	(0 3 0 0)	(0 3 0 0 0)	(0 1 0 0 0)	5,56,6
7-3.1	(07000)	(0 7 0 0 0)	(0 3 0 0 0)	5,, 7
8-4.1	(0 14 0 0 0)	(0 14 0 0 0)	(0 6 0 0 0)	56,, 78
7-2.1	(0 1 2 0 0)	(0 1 0 0 0)	(0 0 1 0 0)	6, 7
8-3.1	(0 3 4 0 0)	(0 3 0 0 0)	(0 1 2 0 0)	6,, 78
9-4.3	(09060)	(0 9 0 6 0)	(0 3 0 4 0)	678,, 789
9-4.5	(0 14 0 0 0)	(0 14 0 0 0)	(06000)	67,, 89
10-5.1	(0 10 16 0 0)	(0 10 0 0 0)	(0 4 8 0 0)	67,, 9 <u>10</u>
11-6.2	(0 26 0 24 0)	(0 26 0 24 0)	(0 10 0 16 0)	78 <u>10</u> ,, 89 <u>10 11</u>
		1	1000	(SA

Major results

- For most designs there exist better foldover plans than the full foldover plan
 - In 52 out of 77 designs have better foldover plans than full-foldover plans
 - Most (42) foldover plans are new
- Almost all minimum aberration designs have better foldover plans

Summary (Li & Lin, 2003)

- Proposed a computer search method to construct optimal foldover plans that minimizes the WLP of the combined design.
- Tabulated optimal foldover plans for commonlyused 16-run and 32-run designs.
- Investigated optimal and full foldover plans by focusing on core foldover plans.
- Demonstrated that there exists a unique group of equivalent foldover plans.
- See also some work of Mee.
- Theory on optimal foldover—Fang, Lin and Qin(2003)





Future work

- Optimal foldover designs of non-regular designs
 - Generalized resolution criterion (Deng and Tang, 1999)
 - Allows "fractional" word length aMiller and Sitter (2001)
 - Willier and Siller (2001
- Optimal semi-foldover designs built on Mee and Peralta (2000) and this work
- Fold over high level designs
- Optimal follow-up experiment, in general.





SUPERSATURATED DESIGN

How can we study k parameters with n(<k) observations (experiments)?

A situation for using supersaturated design:

- A Small number of run is desired
- The number of potential factors is large
- Only a few active factors



New Age SSD Criteria

- E(f_{NOD})
- Discrete Discrepancy
- Minimum Generalized Aberration (MGA)
- Generalized Minimum Aberration (GMA)
- Indicator Function
- Relationships/Connections Among criteria
- Probability of Correct Search

Design Construction

- Half Fraction of Hadamard Matrix
- Random Combined Design (Taguchi, 1986)
- Algorithmic Approach
- Combinatorial Approach
- Optimal Supersaturated Design
- Others

Supersaturated Design From Hadamard Matrix of Order 12 (Using 11 as the branching column)













	UD	OD		SSD
	[11]	[0000]		0000 0000
	27	0 1 1 1		01112021
	33	0222		0222 0222
	49	1012		1012 2210
$U \oplus L =$	55 🕀	1120	= X =	1120 1120
	6 6	1201		1201 1201
	7 2	2021		2021 0111
	88	2102		2102 2102
	94	2210		2210 1012

Data Analysis Methods Supersaturated Design • Pick-the-Winner • Graphical Approach • "PARC" (Practical Accumulation Record Computation) • Compact Two-Sample Test • Forward Selection • Ridge Regression • Normal Plot



SSD: Looking Ahead

Supersaturated Design

- SSD is much more mature than ever
- Nano-Manufacturing Applications
- Micro-Array Design and Analysis
- Computer Experiment: Model Building (using SSD)
- Higher (and Mixed) Level SSD
- Spotlight Interaction Effects (Lin, 1998, QE)
- Combination Designs: Rotated FFD & SSD



Computer Experiment Expensive simulation When Monte Carlo study is infeasible, how to run simulation? Latin Hypercube

Goals—Computer Experiment

- Confirmation
- Sensitivity Analysis
- Empirical Model Building
- Optimization
- Model Validation
- High Dimension Integration



Irrelevant Issues

- Replicates
- Blocking
- Randomization
- Question: How can a computer experiment be run in an efficient manner?

Current Approaches to Experimental Design

- Geometric (Frequentist) Designs
 - Real Full and Fractional Factorial Designs
 - CR Other Traditional Designs
 - Atin Hypercube Designs (McKay, Beckman, and Conover (1979))
- Computer-Generated (Bayesian) Designs
 Aximin Distance Designs (Johnson, Moore, and Ylvisaker (1990))
- Combination Designs (Computer-Generated Geometric)
 Maximin Latin Hypercube Designs (Morris and Mitchell (1992))
 - Orthogonal Array-based LHs (Tang (1993), Owen (1992))
 - Rotated Factorial Designs (Beattie and Lin (1999))

Rotated Factorial Designs

- Computer experiments are gaining in popularity
 - camain research area of the next 10 years
- Rotated factorial designs
- good Latin hypercube properties
 (unique and equally-spaced projections)
 easy to construct
- ce comparable by Bayesian criteria
- eavery suitable for computer experiments









CGA Study

Data:

Central Composite Design in x_1 , $x_2 \& x_3$, with three outputs, y_1 , $y_2 \& y_3$ and three (3) replicates.

Fitted "Location" Models

 $\hat{y}_{\mu_1}(x) = 4.95 + 0.82x_1 - 0.45x_2 - 0.15x_1^2 + 0.28x_2^2 - 0.11x_1x_2 + 0.07x_1x_3$ (R² = 0.91)

 $\hat{y}_{\mu_2}(x) = 0.46 + 0.13x_1 - 0.06x_2 + 0.05x_3 - 0.07x_1^2 - 0.04x_3^2$ (R² = 0.87)

 $\hat{y}_{\mu_3}(x) = 28.36 - 1.48 x_1 + 2.33 x_3 - 0.15 x_1^2 - 1.42 x_2^2 - 0.71 x_1 x_3 \ (\mathbb{R}^2 = 0.12)$

Objective:

Find x^* such that all y_1 , $y_2 \& y_3$ are simultaneously "optimized".

CGA Study

Fitted "Dispersion" Models

 $\hat{y}_{\sigma_1}(\mathbf{x}) = 0.06 + 0.11x_2 + 0.06x_3 + 0.12x_1^2 + 0.11x_3^2 - 0.10x_1x_3 + 0.05x_2x_3 \quad (\mathbf{R}^2 = 0.84)$

 $\hat{y}_{\sigma 2}(\boldsymbol{x}) = 0.02 - 0.01x_1 + 0.01x_2 - 0.01x_3 + 0.02x_3^2 - 0.01x_1x_3 + 0.02x_2x_3 \qquad (\mathbf{R}^2 = 0.83)$

 $\hat{y}_{\sigma_3}(\boldsymbol{x}) = 6.08 - 1.53x_1 + 0.50x_2 + 4.85x_3 + 2.26x_2^2 - 0.65x_1x_3 - 0.67x_1x_2x_3 \qquad (R^2 = 0.95)$

Fitted "Location" Models

 $\hat{y}_{\mu_1}(x) = 4.95 + 0.82x_1 - 0.45x_2 - 0.15x_1^2 + 0.28x_2^2 - 0.11x_1x_2 + 0.07x_1x_3 \quad (\mathbb{R}^2 = 0.91)$

 $\hat{y}_{\mu_2}(x) = 0.46 + 0.13x_1 - 0.06x_2 + 0.05x_3 - 0.07x_1^2 - 0.04x_3^2$ (R² = 0.87)

 $\hat{y}_{\mu_3}(x) = 28.36 - 1.48x_1 + 2.33x_3 - 0.15x_1^2 - 1.42x_2^2 - 0.71x_1x_3$ (R² = 0.12)

Objective:

Find x^* such that all y_1 , $y_2 \& y_3$ are simultaneously "optimized", when both location & dispersion responses are under concerned!.



MRS Optimization : Priority – based Approach

Primary response vs. Secondary responses

Framework

Optimize Primary response

s.t Requirements for secondary responses $\mathbf{x} \in \Omega$

Related Work Hoerl (1959)

Hoerl (1959) Myers and Carter(1973) Biles (1975) Vining and Myers (1990)

Del Castillo and Montgomery (1993) Copeland and Nelson (1996) Semple (1997) Del Castillo, Fan, and Semple (1999)







MRS Optimization : Generalized Distance Approach (cont'd)

Khuri and Conlon (1981)

Distance of Estimated Responses from Estimated "Ideal" Optimum $\rho[\hat{\mathbf{y}}(\mathbf{x}), \phi] = \left[(\hat{\mathbf{y}}(\mathbf{x}) - \phi)' \Sigma^{-1} (\hat{\mathbf{y}}(\mathbf{x}) - \phi) / z'(\mathbf{x}) (\mathbf{X}'\mathbf{X})^{-1} z(\mathbf{x}) \right]^{1/2},$

where $\phi = [\phi, \phi_1, ..., \phi, l]$ is the ideal optimum, $\hat{\Sigma}$ is the estimator of the common variance-covariance matrix of the random errors $(\varepsilon_1, \varepsilon_2, ..., \varepsilon_r)$, X is the design matrix, and $\mathbf{z}(\mathbf{x})$ is a column vector of the input variables of the given model.

Assume All Response Functions - Depend on the same set of input variables. - Are of the same form.



Example : Colloidal Gas Aphrons (CGA) Study

- Characterization of CGA Properties (Jauregi et al. 1997)
- Responses : Stability (y₁, LTB), Volumetric Ratio (y₂, STB), Temperature (y₃, NTB)
- Input Variables : Concentration of Surfactant (x1), Concentration of Salt (x2), Time of Stirring (x3)
- Design : CCD with 8 Factorial Points^{*}, 6 Axial Points^{*}, and a Center Point^{**}

(* Replicated twice, ** Replicated 6 times)

Example : CGA Study (continued)



Example : CGA Study (continued)

	Responses			
	y ₁	<i>y</i> ₂	<i>y</i> ₃	
Bounds and Target				
$\mathcal{Y}_{\mu_{j}}^{\min}$, $\mathcal{Y}_{\sigma_{j}}^{\min}$	3.00, 0.00	0.10, 0.00	15.00, 1.00	
$y_{\mu j}$, $y_{\sigma j}$	7.00, <mark>0.10</mark>	0.60, 0.10	45.00, 2.00	
T_{μ_j} , T_{σ_j}	7.00, <mark>0.00</mark>	0.10, 0.00	30.00, 1.00	
Optimization Results				
DS Method	$x_{DS}^{*} = (-1.0)$	0, -1.00, -1.00)		
$\hat{y}_{\mu_j}(\mathbf{x}_{DS}^{*})$, $\hat{y}_{\sigma,j}(\hat{\mathbf{x}}_{DS}^{*})$	4.66, 0.06	0.24, 0.08	25.38, 4.54	
$d_{\mu_{j}}(\hat{y}_{\mu_{j}}(\mathbf{x}_{DS} *)), d_{\sigma_{j}}(\hat{y}_{\sigma_{j}}(\mathbf{x}_{DS} *))$	0.41, 0.41	0.72, <i>0.23</i>	0.69, <u>0.00</u>	
[†] The \hat{y}_{σ_j} and $d_{\sigma_j}(\hat{y}_{\sigma_j})$ values for the standard dev and are written in italic.	iation responses a	are computed a posteri	<i>ori</i> at the given x_{DS}^* ,	
tted "Dispersion" Mode	ls			
$\hat{y}_{\sigma_1}(\boldsymbol{x}) = 0.06 + 0.11x_2 + 0.06x_3 + 0.12$	$2x_1^2 + 0.11x_3^2$	$x_{1}^{2} - 0.10x_{1}x_{3} + 0.0$	$0.5x_2x_3$ (R ² = 0.84	4)
$\hat{y}_{\sigma 2}(\boldsymbol{x}) = 0.02 - 0.01 x_1 + 0.01 x_2 - 0.01.$	$x_3 + 0.02x_3^2 -$	$-0.01x_Ix_3 + 0.02$	$x_2 x_3$ (R ² = 0.83)	5
$\hat{y}_{\sigma_3}(\boldsymbol{x}) = 6.08 - 1.53x_1 + 0.50x_2 + 4.85$	$5x_3 + 2.26 x_2^2$	$-0.65x_1x_3 - 0.67$	$x_1 x_2 x_3 \qquad (\mathbf{R}^2 = 0.$	95





	Responses				
	<i>y</i> ₁	<i>y</i> ₂	<i>y</i> ₃		
Bounds and Target					
$y_{\mu j}^{\min}$, $y_{\sigma j}^{\min}$	3.00, 0.00	0.10, 0.00	15.00, 1.00		
y_{μ_j} , y_{σ_j}	7.00, 0.10	0.60, 0.10	45.00, 2.00		
T_{μ_j} , T_{σ_j}	7.00, 0.00	0.10, 0.00	30.00, 1.00		
Optimization Results					
DS Method	$x_{DS}^{*} = (-1.00)$, -1.00, -1.00)			
$\hat{y}_{\mu_{j}}(\mathbf{x}_{DS} \cdot)$, $\hat{y}_{\sigma_{j}}(\mathbf{x}_{DS} \cdot)$	4.66, 0.06	0.24, 0.08	25.38, 4.54		
$_{\mu_{j}}(\hat{y}_{\mu_{j}}(\mathbf{x}_{DS} \ast)), d_{\sigma_{j}}(\hat{y}_{\sigma_{j}}(\mathbf{x}_{DS} \ast))$	0.41, 0.41	0.72, 0.23	0.69, <u>0.00</u>		
Proposed Method	$x_p^* = (-0.21,$	-0.40, -1.00)			
$\hat{y}_{\mu_{j}}(\mathbf{x}_{P}), \hat{y}_{\sigma_{j}}(\mathbf{x}_{P})$	5.00, 0.06	0.37, 0.05	25.96, 1.64		
$d_{\mu_i}(\hat{y}_{\mu_i}(\mathbf{x}_{p^*})), d_{\sigma_i}(\hat{y}_{\sigma_i}(\mathbf{x}_{p^*}))$	0.50, 0.36	0.45, 0.50	0.73, 0.36		

Proposed Approach : General Properties

- Advantages
 - Good Balance among Responses on Both Location and Dispersion
 Effects
 - Robust to Potential Dependencies among Responses
 - Representation of
- Disadvantages
 - Output Solutions Possible
 - e.g. Let $d = (d_{\mu 1}, d_{\mu 2}, d_{\sigma 1}, d_{\sigma 2})$
 - $d_1 = (0.5, 0.5, 0.5, 0.5)$ vs. $d_2 = (0.99, 0.99, 0.99, 0.49)$ $d_1 = (0.5, 0.5, 0.5, 0.5)$ vs. $d_3 = (0.99, 0.99, 0.99, 0.50)$
 - Costs for Required Replication

Micro-Array Design (SS Young)

- How do you pick the sequences that you are going to use.
 They have to be unique vs other sub-sequences and they have to work at common temperature/chemical fluid concentrations.
- Placement of sub sequences on the chip and the number of rep spots.
- A no-no is possible reuse of chips. How to wash would be a good DOE problem.
 - ca Technically I think the chips can be reused, but contract requires only one use.
- There is very large variation in response among the subsequences within a gene. Does this relate to the sequence in some way?
 - If so, it would be of interest to try to figure out the factors influencing the among sub-sequence variation. So the question would be DOE on the selection of the subsequence and then DOE on the assay conditions.

Where have all the Data gone?

- No need for data (Theoretical Development)
- Survey Sampling and Design of Experiment (Physical data collection)
- - a Statistical Simulation
 - (Random Number generation)
 - Engineering Simulation
- Data from Internet
 On-line auction
 - Search Engine



Send \$500 to

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